



SHEET 1 OF 3

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
043888-0267

SERIAL NO.
10/629,815

APPLICANT
Tsutomu OHZUKU, et al.

FILING DATE
July 30, 2003

GROUP
1745

U.S. PATENT DOCUMENTS

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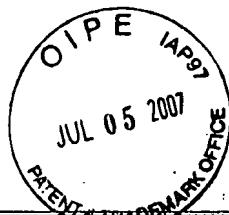
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/CL/		JP 2004-002141	01-08-2004	TOSOH CORP		JAPAN (w/English Translation)
/CL/		JP 2001-332261	11-30-2001	TOYOTA MOTOR CORP		JAPAN (w/English Translation)
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/CL/		Japanese Office Action issued in Japanese Patent Application No. JP 2003-281871, mailed April 12, 2007.				
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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CL		JP 2003-221236	08-05-2003	HITACHI MAXELL LTD	Corresponds to US 2004/0110063 A1	X	

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<i>Ch</i>				Japanese Office Action, Issued in Japanese Patent Application No. 2002-303294, dated on September 21, 2007

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